

# SA58640

## Low-voltage mixer FM IF system

Rev. 01 — 6 April 2005

Product data sheet

## 1. Introduction

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The SA58640 was designed for cordless telephone applications in which efficient and economic integrated solutions are required and yet high performance is desirable. Although the product is not targeted to meet the stringent specifications of high performance cellular equipment, it will exceed the needs for analog cordless phones. The minimal amount of external components and absence of any external adjustments makes for a very economical solution.

## 2. General description

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The SA58640 is a low-voltage monolithic FM IF system incorporating a mixer/oscillator, two limiting intermediate frequency amplifiers, quadrature detector, logarithmic RSSI, voltage regulator and audio and RSSI opamps. The SA58640 is available in a 20-pin SSOP package.

## 3. Features

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- Low power consumption: 5.0 mA typical at 5 V
- Mixer input to >100 MHz
- Mixer conversion power gain of 17 dB at 45 MHz
- Crystal oscillator effective to 100 MHz (LC oscillator or external oscillator can be used at higher frequencies)
- 102 dB of IF amp/limiter gain
- 2 MHz IF amp/limiter small signal bandwidth
- Temperature compensated logarithmic RSSI with a 70 dB dynamic range
- Low external component count; suitable for crystal/ceramic/LC filters
- Audio output internal opamp
- RSSI output internal opamp
- Internal opamps with rail-to-rail outputs
- ESD protection: Human body model 2 kV; robot model 200 V.

## 4. Applications

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- Cordless phones.

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## 7.2 Pin description

Table 2: Pin description

| Symbol          | Pin | Description                              |
|-----------------|-----|--|
| RF_IN_P         | 1   | positive RF mixer input                  |
| RF_IN_N_DEC     | 2   | negative RF mixer input, decoupling      |
| OSCOUT          | 3   | oscillator output (emitter)              |
| OSCIN           | 4   | oscillator input (base)                  |
| RSSI_OUT        | 5   | RSSI amplifier output                    |
| V <sub>CC</sub> | 6   | positive supply                          |
| AUDIO_FB        | 7   | audio amplifier negative input, feedback |
| AUDIO_OUT       | 8   | audio amplifier output                   |
| RSSI_FB         | 9   | RSSI amplifier negative input, feedback  |
| QUAD_IN         | 10  | quadrature detector input                |
| LIM_OUT         | 11  | limiter amplifier output                 |
| LIM_DEC         | 12  | limiter decoupling                       |
| LIM_DEC         | 13  | limiter decoupling                       |
| LIM_IN          | 14  | limiter amplifier input                  |
| GND             | 15  | ground                                   |
| IF_AMP_OUT      | 16  | IF amplifier output                      |
| IF_AMP_DEC      | 17  | IF amplifier decoupling                  |
| IF_AMP_IN       | 18  | IF amplifier input                       |
| IF_AMP_DEC      | 19  | IF amplifier decoupling                  |
| MIXER_OUT       | 20  | mixer output                             |

## 8. Functional description

The SA58640 is an IF signal processing system suitable for second IF systems with input frequency as high as 100 MHz. The bandwidth of the IF amplifier and limiter is at least 2 MHz with 90 dB of gain. The gain/bandwidth distribution is optimized for 455 kHz, 1.5 kΩ source applications. The overall system is well-suited to battery operation as well as and high quality products of all types.

The input stage is a Gilbert cell mixer with oscillator. Typical mixer characteristics include a noise figure of 7.0 dB, conversion gain of 17 dB, and input third-order intercept of -10 dBm. The oscillator will operate in excess of 100 MHz in LC tank configurations. Hartley or Colpitts circuits can be used up to 100 MHz for crystal configurations.

The output impedance of the mixer is a 1.5 kΩ resistor permitting direct connection to a 455 kHz ceramic filter. The input resistance of the limiting IF amplifiers is also 1.5 kΩ. With most 455 kHz ceramic filters and many crystal filters, no impedance matching network is necessary. The IF amplifier has 44 dB of gain and 5.5 MHz bandwidth. The IF limiter has 58 dB of gain and 4.5 MHz bandwidth. To achieve optimum linearity of the log signal strength indicator, there must be a 12 dB(V)<sup>1</sup> insertion loss between the first and second IF stages. If the IF filter or interstage network does not cause 12 dB(V) insertion loss, a

1.  $\text{dB(V)} = 20 \log V_o/V_i$

fixed or variable resistor or an L pad for simultaneous loss and impedance matching can be added between the first IF output (pin 16) and the interstage network. The overall gain will then be 90 dB with 2 MHz bandwidth.

The signal from the second limiting amplifier goes to a Gilbert cell quadrature detector. One port of the Gilbert cell is internally driven by the IF. The other output of the IF is AC-coupled to a tuned quadrature network. This signal, which now has a 90° phase relationship to the internal signal, drives the other port of the multiplier cell.

The demodulated output of the quadrature drives an internal opamp. This opamp can be configured as a unity gain buffer, or for simultaneous gain, filtering, and 2nd-order temperature compensation if needed. It can drive an AC load as low as 10 kΩ with a rail-to-rail output.

A log signal strength indicator completes the circuitry. The output range is greater than 70 dB and is temperature compensated. This signal drives an internal opamp. The opamp is capable of rail-to-rail output. It can be used for gain, filtering, or 2nd-order temperature compensation of the RSSI, if needed.

## 9. Limiting values

**Table 3: Limiting values**

In accordance with the Absolute Maximum Rating System (IEC 60134).

| Symbol    | Parameter                           | Conditions | Min | Max | Unit |
|-----------|-------------------------------------|------------|-----|-----|------|
| $V_{CC}$  | single supply voltage               |            | -   | 7   | V    |
| $T_{stg}$ | storage temperature range           |            | -65 | 150 | °C   |
| $T_{amb}$ | operating ambient temperature range |            | -40 | 85  | °C   |
| $Z_{th}$  | thermal impedance                   |            | -   | 117 | K/W  |

## 10. Static characteristics

**Table 4: Static characteristics**

$T_{amb} = 25\text{ °C}$ ;  $V_{CC} = +5\text{ V}$ , unless otherwise stated. [1]

| Symbol   | Parameter                  | Conditions | Min | Typ | Max | Unit |
|----------|----------------------------|------------|-----|-----|-----|------|
| $V_{CC}$ | power supply voltage range |            | 4.5 | -   | 6.0 | V    |
| $I_{CC}$ | DC current drain           |            | -   | 5.0 | 6.0 | mA   |

- [1] RF frequency = 45 MHz; +14.5 dBV RF input step-up; IF frequency = 455 kHz; R17 = 2.4 k $\Omega$  and R18 = 3.3 k $\Omega$ ; RF level = -45 dBm; FM modulation = 1 kHz with  $\pm 5$  kHz peak deviation. Audio output with de-emphasis filter and C-message weighted filter. See [Figure 3 "45 MHz application circuit" on page 7](#). The parameters listed above are tested using automatic test equipment to assure consistent electrical characteristics. The limits do not represent the ultimate performance limits of the device. Use of an optimized RF layout will improve many of the listed parameters.

## 11. Dynamic characteristics

Table 5: Dynamic characteristics

| Symbol   | Parameter  | Conditions   | Min  | Typ  | Max | Unit       |
|--|--|--|------|------|-----|------------|
| <b>Mixer/oscillator section (external LO = 220 mV<sub>RMS</sub>)</b> |  |  |      |      |     |            |
| $f_{in}$   | input frequency  |  | -    | 100  | -   | MHz        |
| $f_{osc}$  | crystal oscillator frequency                           |  | -    | 100  | -   | MHz        |
|  | noise figure at 45 MHz                                 |  | -    | 7.0  | -   | dB         |
|  | third-order input intercept point (50 $\Omega$ source) | $f_1 = 45.0$ ; $f_2 = 45.06$ MHz<br>Input RF level = -52 dBm | -    | -10  | -   | dBm        |
| $P_{G(conv)}$  | conversion power gain                                  | matched 14.5 dBV step-up                                     | 10   | 17   | -   | dB         |
|  |  | 50 $\Omega$ source   | -    | +2.5 | -   | dB         |
| $R_{i(RF)}$  | RF input resistance                                    | single-ended input   | -    | 8    | -   | k $\Omega$ |
| $C_{i(RF)}$  | RF input capacitance                                   |  | -    | 3.0  | 4.0 | pF         |
| $R_{o(mix)}$   | mixer output resistance                                | measured on pin 20   | 1.25 | 1.5  | -   | k $\Omega$ |
| <b>IF section</b>  |  |  |      |      |     |            |
| $G_{a(IF)}$  | IF amp gain  | 50 $\Omega$ source   | -    | 44   | -   | dB         |
| $L_G$  | limiter gain   | 50 $\Omega$ source   | -    | 58   | -   | dB         |
|  | AM rejection   | 30 % AM 1 kHz  | -    | 50   | -   | dB         |
|  | audio level  | gain of two  | 60   | 120  | -   | mV         |
|  | SINAD sensitivity                                      | IF level = -110 dBm  | -    | 17   | -   | dB         |
| THD  | total harmonic distortion                              |  | -    | -55  | -   | dB         |
| S/N  | signal-to-noise ratio                                  | no modulation for noise                                      | -    | 60   | -   | dB         |
|  | IF RSSI output, $R_9 = 2$ k $\Omega$ [1]               | IF level = -110 dBm  | -    | 0.5  | 1.0 | V          |
|  |  | IF level = -50 dBm   | -    | 1.7  | 2.4 | V          |
|  | RSSI range   |  | -    | 60   | -   | dB         |
| $Z_{i(IF)}$  | IF input impedance                                     | measured on pin 18   | 1.3  | 1.5  | -   | k $\Omega$ |
| $Z_{o(IF)}$  | IF output impedance                                    | measured on pin 16   | -    | 0.3  | -   | k $\Omega$ |
| $Z_{i(lim)}$   | limiter input impedance                                | measured on pin 14   | 1.3  | 1.5  | -   | k $\Omega$ |
| $Z_{o(lim)}$   | limiter output impedance                               | measured on pin 11   | -    | 0.3  | -   | k $\Omega$ |
| $V_{o(lim)(rms)}$  | limiter output voltage                                 | measured on pin 11   | -    | 130  | -   | mV         |
| <b>RF/IF section (internal LO)</b>                                   |  |  |      |      |     |            |
|  | system SINAD sensitivity                               | RF level = -110 dBm  | -    | 12   | -   | dB         |

[1] The generator source impedance is 50  $\Omega$ , but the SA58640 input impedance at pin 18 is 1500  $\Omega$ . As a result, IF level refers to the actual signal that enters the SA58640 IF amplifier input (pin 18) which is about 21 dB less than the 'available power' at the generator.

## 12. Application information

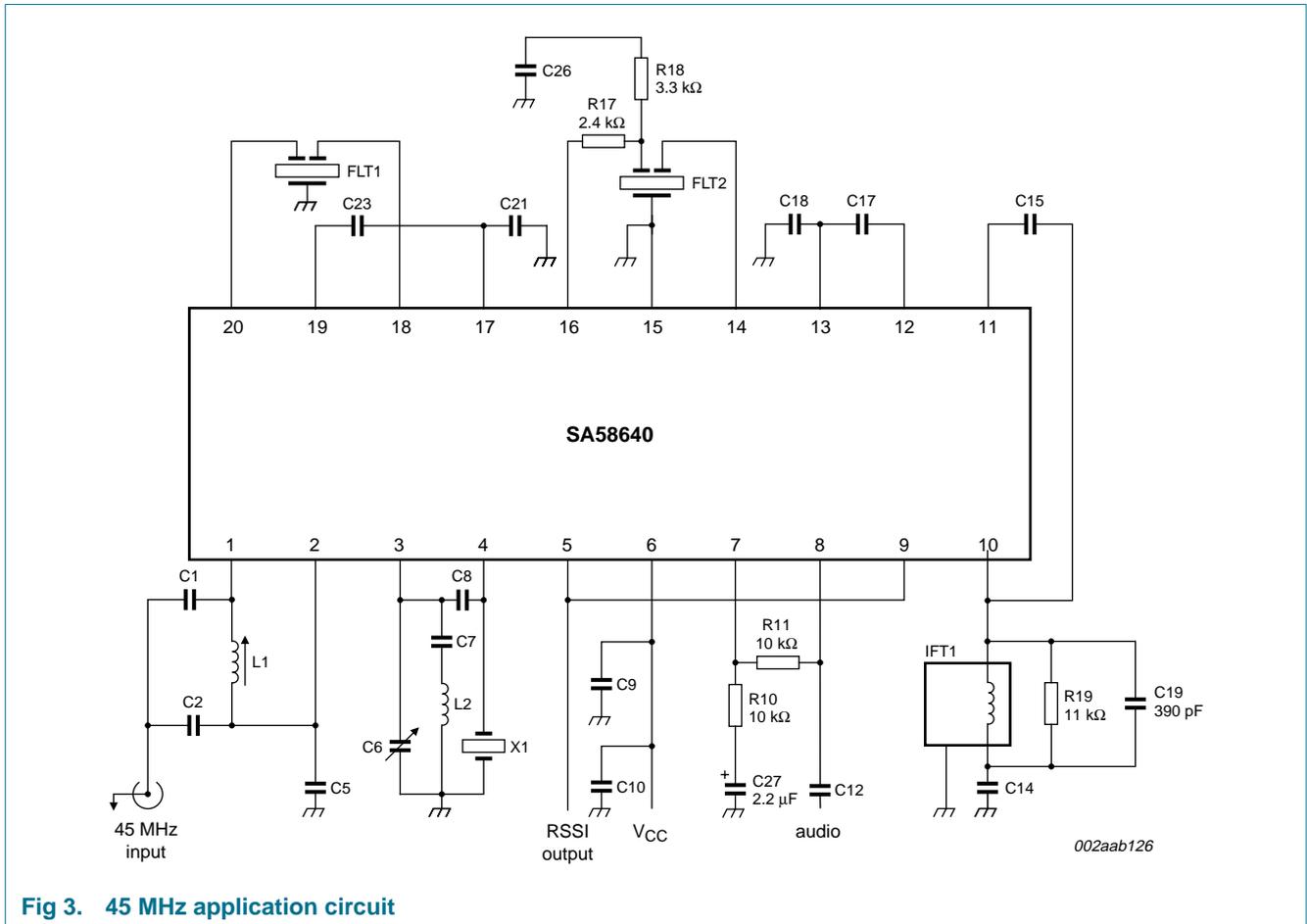


Fig 3. 45 MHz application circuit

Table 6: Demo board application component list

| Component | Value         | Type                              |
|-----------|---------------|-----------------------------------|
| C1        | 51 pF         | NPO ceramic                       |
| C2        | 220 pF        | NPO ceramic                       |
| C5        | 100 nF ± 10 % | monolithic ceramic                |
| C6        | 5 pF to 30 pF | trim cap                          |
| C7        | 1 nF          | ceramic                           |
| C8        | 10.0 pF       | NPO ceramic                       |
| C9        | 100 nF ± 10 % | monolithic ceramic                |
| C10       | 10 μF         | tantalum (minimum) <sup>[1]</sup> |
| C12       | 2.2 μF ± 10 % | tantalum                          |
| C14       | 100 nF ± 10 % | monolithic ceramic                |
| C15       | 10 pF         | NPO ceramic                       |
| C17       | 100 nF ± 10 % | monolithic ceramic                |
| C18       | 100 nF ± 10 % | monolithic ceramic                |
| C19       | 390 pF ± 10 % | monolithic ceramic                |

Table 6: Demo board application component list ...continued

| Component | Value  | Type  |
|-----------|--|---|
| C21       | 100 nF ± 10 %  | monolithic ceramic                                  |
| C23       | 100 nF ± 10 %  | monolithic ceramic                                  |
| C26       | 100 nF ± 10 %  | monolithic ceramic                                  |
| C27       | 2.2 µF   | tantalum  |
| FLT1      | -  | ceramic filter Murata CFUCF455KB4X-R0 or equivalent |
| FLT2      | -  | ceramic filter Murata CFUCF455KB4X-R0 or equivalent |
| IFT1      | 330 µH   | TOKO 836AN-0129Z                                    |
| L1        | 330 nH   | TOKO A638AN-0158Z                                   |
| L2        | 1.2 µH nominal   | FSLM2520-12K  |
| X1        | 44.545 MHz   | crystal ICM4712701                                  |
| R5        | not used in application board (see list item <a href="#">8 on page 9</a> ) | -   |
| R10       | 8.2 kΩ ± 5 %   | ¼ W carbon composition                              |
| R11       | 10 kΩ ± 5 %  | ¼ W carbon composition                              |
| R17       | 2.4 kΩ ± 5 %   | ¼ W carbon composition                              |
| R18       | 3.3 kΩ ± 5 %   | ¼ W carbon composition                              |
| R19       | 11 kΩ ± 5 %  | ¼ W carbon composition                              |

[1] This value can be reduced when a battery is the power source.

### 13. Test information

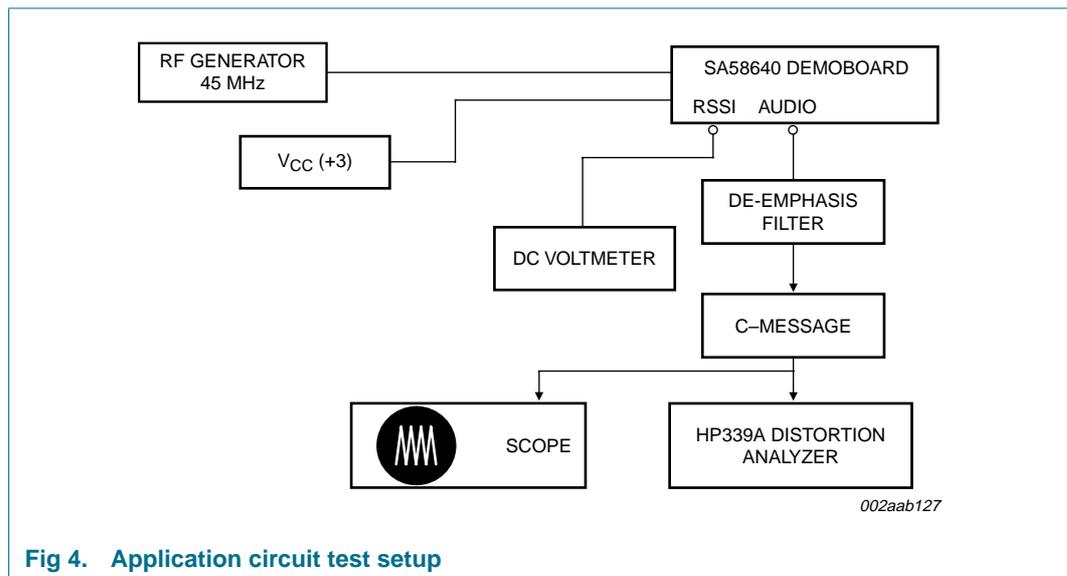


Fig 4. Application circuit test setup

The following list items [1](#) through [8](#) apply to [Figure 4](#):

1. The C-message and de-emphasis filter combination has a peak gain of 10 for accurate measurements. Without the gain, the measurements may be affected by the noise of the scope and HP339A analyzer. The de-emphasis filter has a fixed  $-6$  dB/Octave slope between 300 Hz and 3 kHz.
2. The ceramic filters can be 30 kHz SFG455A3s made by Murata which have 30 kHz IF bandwidth (they come in blue), or 16 kHz CFU455Ds, also made by Murata (they come in black). All specifications and testing are done with the wideband filter.
3. Set your RF generator at 45.000 MHz, use a 1 kHz modulation frequency and a 6 kHz deviation if you use 16 kHz filters, or 8 kHz if you use 30 kHz filters.
4. The measured typical sensitivity for 12 dB SINAD should be  $0.45 \mu\text{V}$  or  $-114$  dBm at the RF input.
5. The layout is very critical in the performance of the receiver. We highly recommend our demo board layout.
6. The smallest RSSI voltage (i.e., when no RF input is present and the input is terminated) is a measure of the quality of the layout and design. If the lowest RSSI voltage is 500 mV or higher, it means the receiver is in regenerative mode. In that case, the receiver sensitivity will be worse than expected.
7. All of the inductors, the quad tank, and their shield must be grounded. A  $10 \mu\text{F}$  to  $15 \mu\text{F}$  or higher value tantalum capacitor on the supply line is essential. A low frequency ESR screening test on this capacitor will ensure consistent good sensitivity in production. A  $0.1 \mu\text{F}$  bypass capacitor on the supply pin  $V_{CC}$ , and grounded near the 44.545 MHz oscillator improves sensitivity by 2 dB to 3 dB.
8. R5 can be used to bias the oscillator transistor at a higher current for operation above 45 MHz. Recommended value is  $22 \text{ k}\Omega$ , but should not be below  $10 \text{ k}\Omega$ .

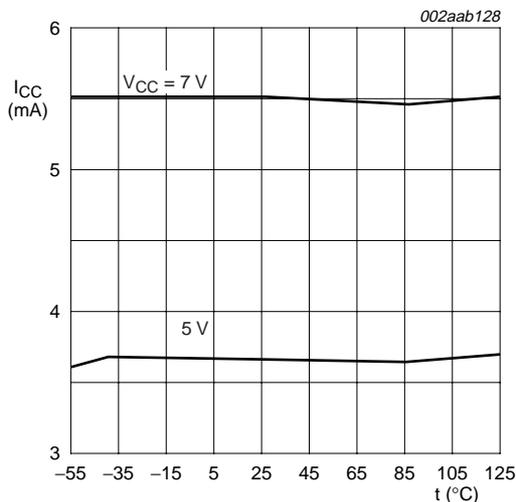
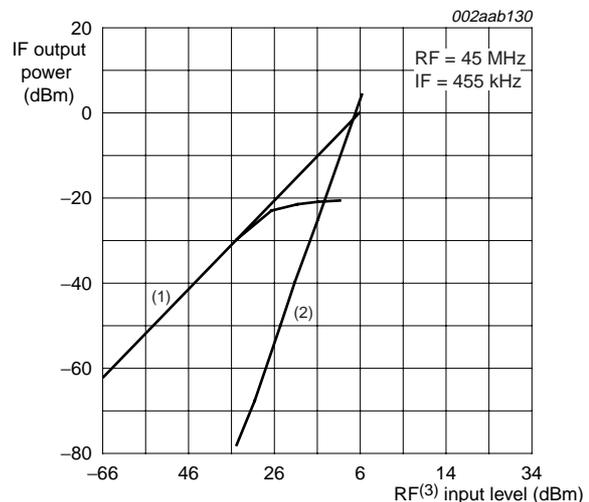
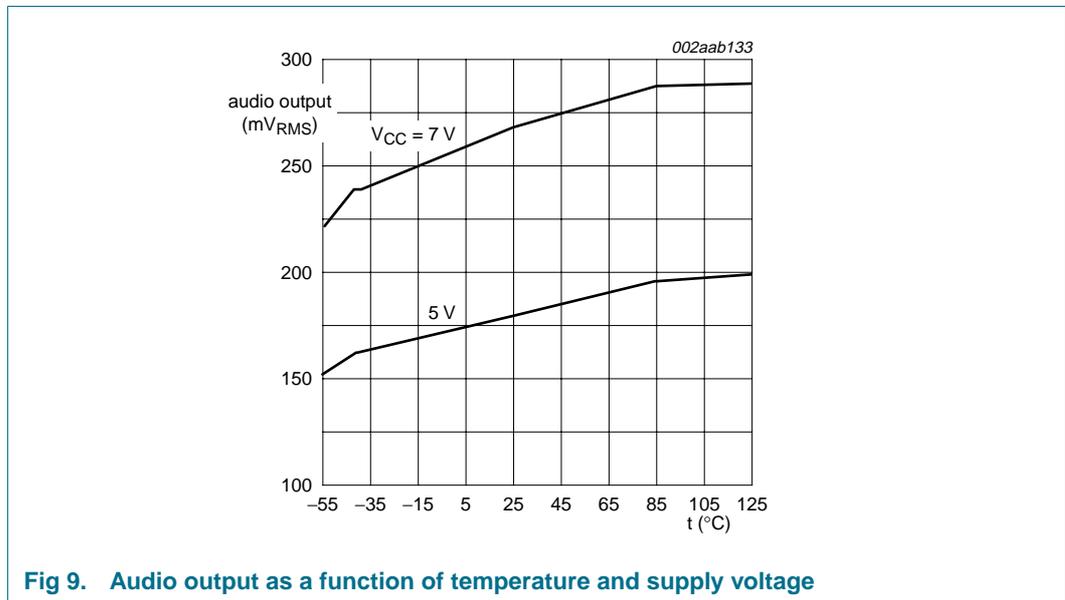
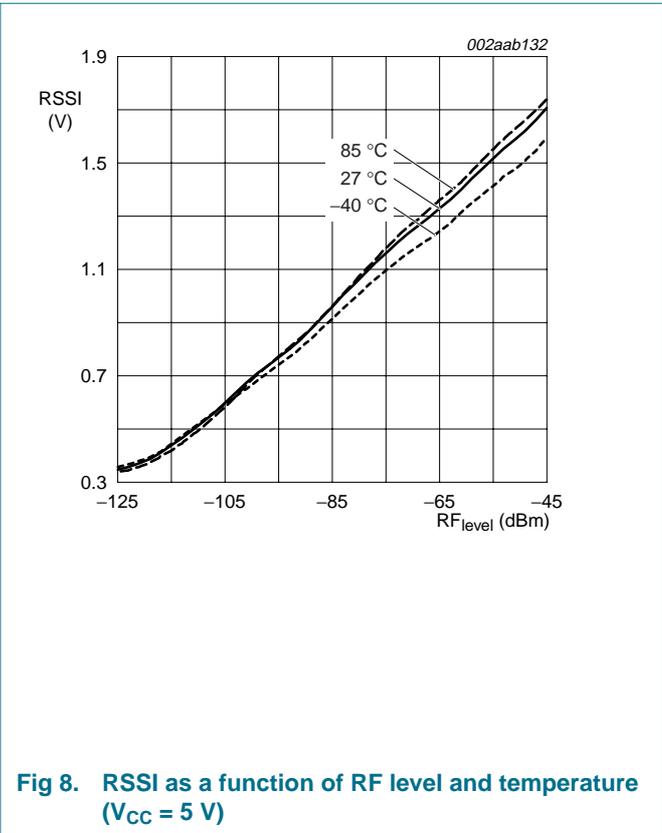
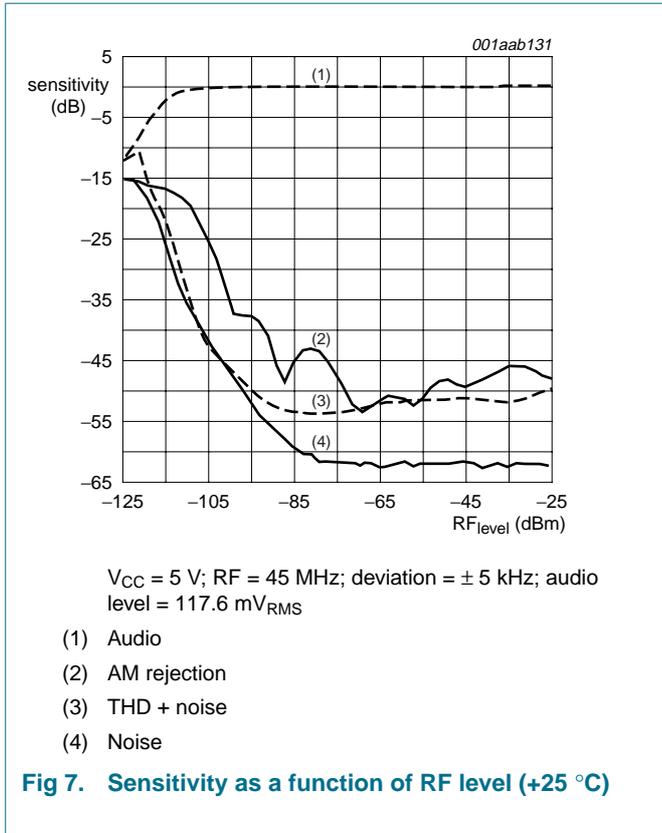


Fig 5.  $I_{CC}$  as a function of temperature and supply voltage



(1) Fund product  
(2) 3rd order product  
(3)  $50 \Omega$  input

Fig 6. Mixer third order intercept and compression



14. Package outline

SSOP20: plastic shrink small outline package; 20 leads; body width 4.4 mm

SOT266-1

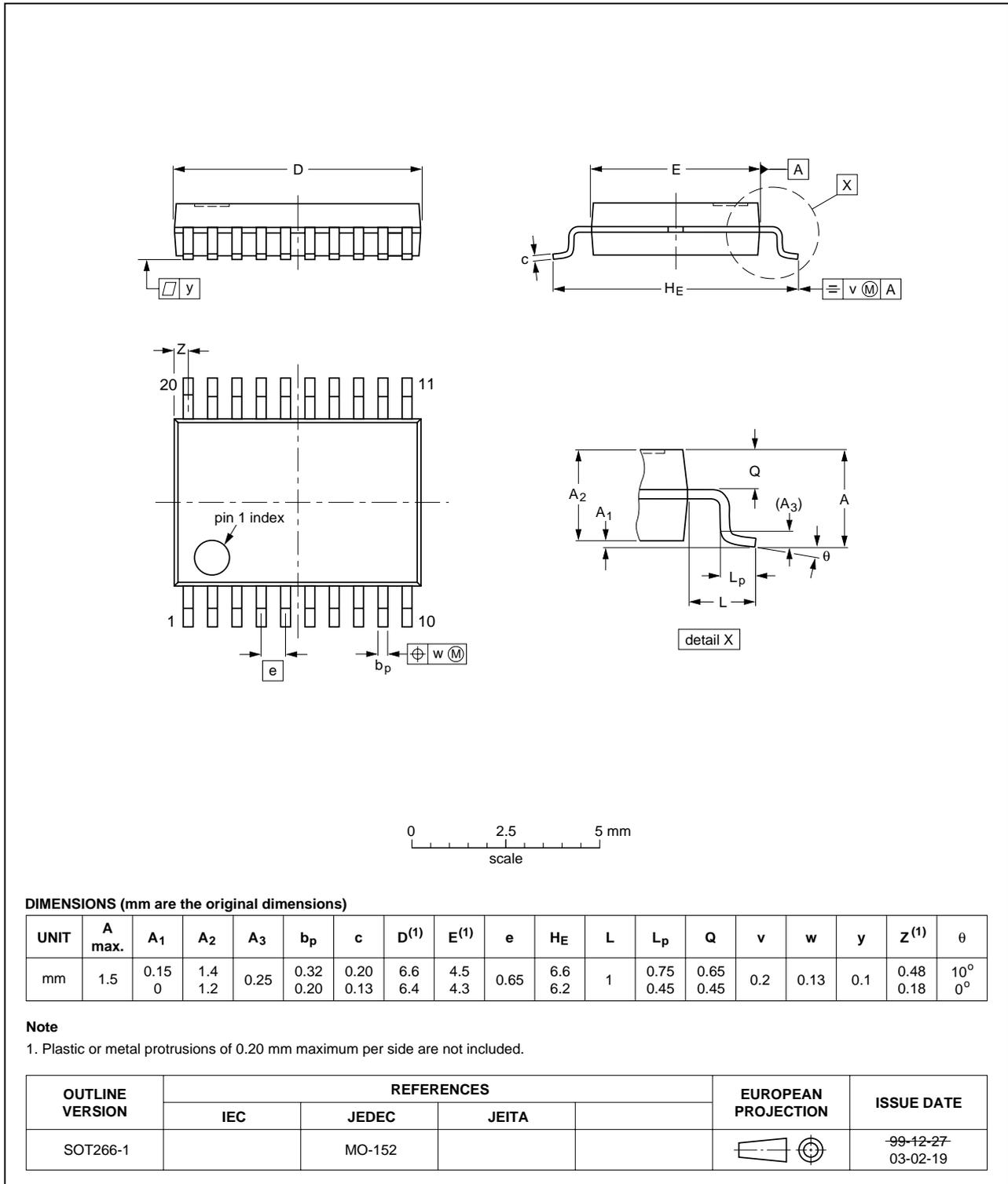


Fig 10. Package outline SOT266-1 (SSOP20)

## 15. Abbreviations

Table 7: Abbreviations

| Acronym | Description                          |
|---------|--------------------------------------|
| AC      | Alternating Current                  |
| AM      | Amplitude Modulation                 |
| ESD     | Electrostatic Discharge              |
| ESR     | Equivalent Series Resistance         |
| FM      | Frequency Modulator                  |
| IF      | Intermediate Frequency               |
| LO      | Local Oscillator                     |
| RF      | Radio Frequency                      |
| RSSI    | Received Signal Strength Indicator   |
| SINAD   | Signal-to-Noise And Distortion ratio |
| SSOP    | Shrink Small Outline Package         |
| THD     | Total Harmonic Distortion            |

## 16. Revision history

Table 8: Revision history

| Document ID | Release date | Data sheet status  | Change notice | Doc. number    | Supersedes |
|-------------|--------------|--------------------|---------------|----------------|------------|
| SA58640_1   | 20050406     | Product data sheet | -             | 9397 750 14161 | -          |

## 17. Data sheet status

| Level | Data sheet status <sup>[1]</sup> | Product status <sup>[2]</sup> <sup>[3]</sup> | Definition   |
|-------|----------------------------------|--|--|
| I     | Objective data                   | Development                                  | This data sheet contains data from the objective specification for product development. Philips Semiconductors reserves the right to change the specification in any manner without notice.  |
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[3] For data sheets describing multiple type numbers, the highest-level product status determines the data sheet status.

## 18. Definitions

**Short-form specification** — The data in a short-form specification is extracted from a full data sheet with the same type number and title. For detailed information see the relevant data sheet or data handbook.

**Limiting values definition** — Limiting values given are in accordance with the Absolute Maximum Rating System (IEC 60134). Stress above one or more of the limiting values may cause permanent damage to the device. These are stress ratings only and operation of the device at these or at any other conditions above those given in the Characteristics sections of the specification is not implied. Exposure to limiting values for extended periods may affect device reliability.

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Date of release: 6 April 2005  
Document number: 9397 750 14161

Published in The U.S.A.